

Search Notes

Application/Control No.

10/562,846

Examiner

Yuwen Pan

Applicant(s)/Patent under
Reexamination

RATERMANN ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	41.3,41.2, 41.1,507,5 09,512	4/25/2007	YP
370	449,455		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/25/2007	YP